

# DUAL POWER SCHOTTKY RECTIFIERS

60A Pk, 45V

USD335C

USD345C

USD335CHR2

USD345CHR2

2

## FEATURES

- Very Low Forward Voltage
- Low Recovered Charge
- Rugged Package Design (TO-3)
- High Efficiency for Low Voltage Supplies
- 45V Blocking @ Rated  $T_{J\max}$
- 50V Repetitive Surge Voltage
- Dual Schottky Rectifier in a Single Package

## ABSOLUTE MAXIMUM RATINGS (Total for USD300C Series)

Average Rectified Forward Current,  $I_0$  @  $T_c = 100^\circ\text{C}$  ..... 30A .....

## ABSOLUTE MAXIMUM RATINGS (Per Diode)

Working Peak Reverse Voltage  $V_{RWM}$  ..... 35V ..... 45V .....

DC Blocking Voltage,  $V_R$  ..... 35V ..... 45V .....

Peak Repetitive Surge Voltage,  $V_{RSM} @ I_{FSM}$  ..... 42V ..... 54V .....

Average Rectified Forward Current,  $I_0$  ..... 30A in full wave configuration\* .....

Non-repetitive Peak Surge current (8.3 mS),  $I_{FSM}$  ..... 500A .....

Peak Reverse Transient Current,  $I_{RM}$  ..... 2A .....

Storage Temperature Range,  $T_{STG}$  .....  $-55^\circ\text{C}$  to  $+200^\circ\text{C}$  .....

Peak Operating Junction Temperature,  $T_{J\max}$  .....  $175^\circ\text{C}$  .....

Thermal Resistance, Junction to Case,  $R_{\theta JC}$  .....  $1.4^\circ\text{C/W}$  .....

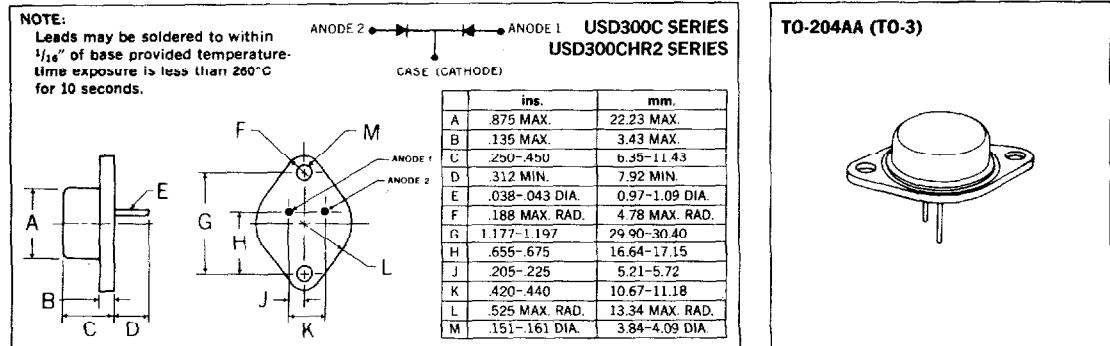
\* Each Anode Pin Limited to 18A Average.

Package Capability 30A Average.

## ELECTRICAL CHARACTERISTICS ( $T_{CASE} = 25^\circ\text{C}$ )

Characteristic	Symbol	Limit	Units	Conditions
Maximum Instantaneous Reverse Current	$i_R$	10 50	mA mA	$T_c = 25^\circ\text{C}, V_R = V_{RWM}$ $T_c = 125^\circ\text{C}$ Pulse Width = $400\mu\text{s}$ Duty Cycle = 1 percent
Maximum Instantaneous Forward Voltage	$V_F$	0.57 0.66 0.60	V V V	$i_F = 10\text{A}, T_c = 25^\circ\text{C}$ $i_F = 20\text{A}, T_c = 25^\circ\text{C}$ $i_F = 20\text{A}, T_c = 125^\circ\text{C}$ Pulse Width = $300\mu\text{s}$ Duty Cycle = 1 percent
Capacitance	$C_t$	2000	pF	$V_R = 5.0\text{V}$
Voltage Rate of Change	$dv/dt$	1000	v/ $\mu\text{s}$	$V_R = V_{RWM}$

## MECHANICAL SPECIFICATIONS

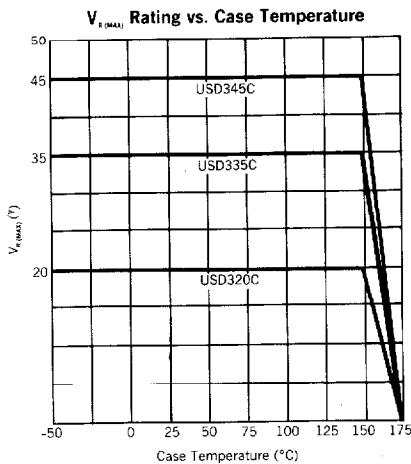
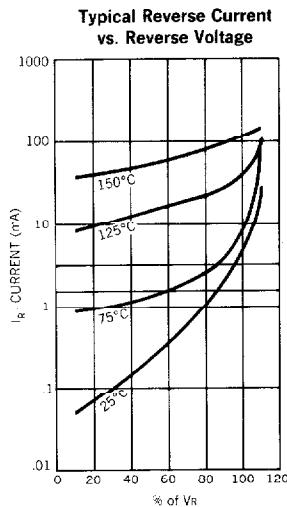
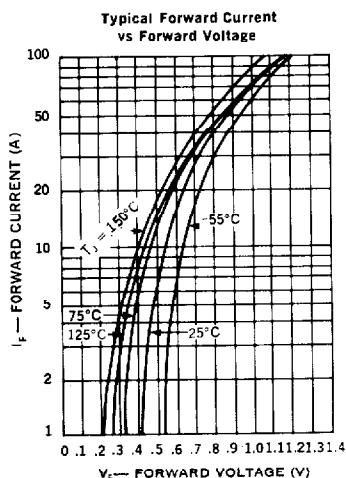


Notes: All metal surfaces tin plated.

**Microsemi Corp.**

**Watertown**

The diode experts



#### OPTIONAL HIGH RELIABILITY (HR2) SCREENING

The following tests are performed on 100% of the devices specified USD335CHR2, 345CHR2.

SCREEN	MIL-STD-750 METHOD	CONDITIONS
1. High Temperature	1032	24 hours @ T <sub>A</sub> = 150°C
2. Temperature Cycle	1051	F, 20 Cycles, -55 to +150°C. No dwell required @ 25°C, t ≥ 10 min. @ extremes
3. Hermetic Seal a. Fine Leak b. Gross Leak	1071	H, Helium C, Liquid
4. Thermal Impedance		Sage Test
5. Interim Electrical Parameters	GO/NO GO	V <sub>F</sub> and I <sub>R</sub> @ 25°C
6. High Temperature Reverse Blocking	Similar to Method 1040	½ Sine Reverse, t = 48 Hours, T <sub>C</sub> = 125°C, VRW <sub>M</sub> = rating, F = 50-60 Hz, I <sub>O</sub> = OA
7. Final Electrical Parameters	GO/NO GO	V <sub>F</sub> + I <sub>R</sub> @ 25°C PDA = 10% (Final Electricals)